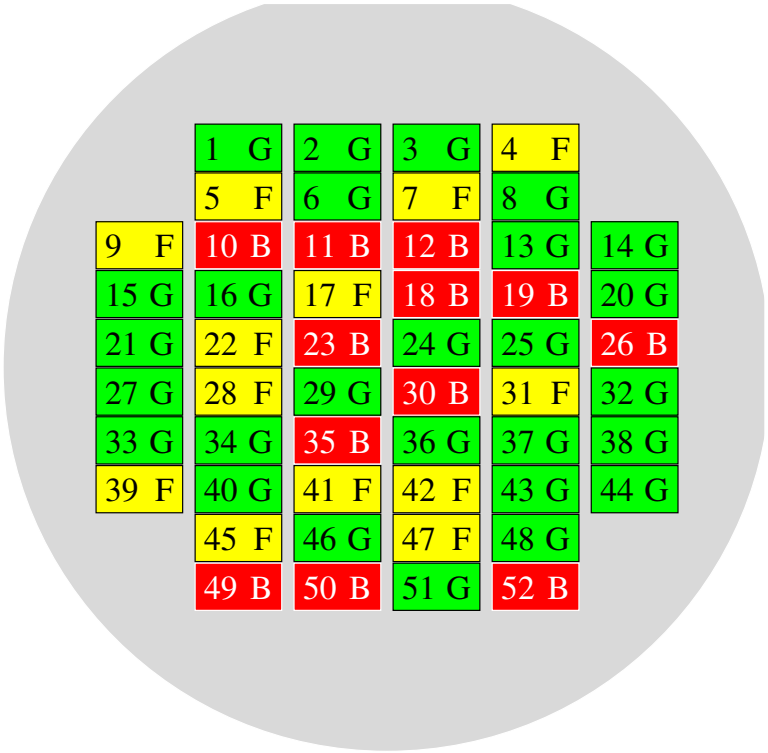
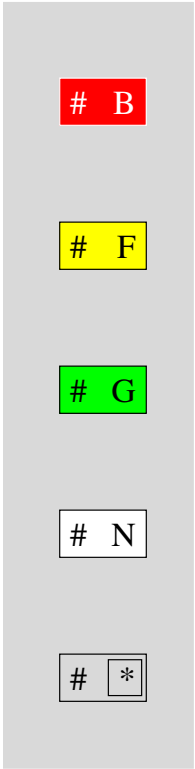
Die quality map for wafer 148 s/n: 21316-02-04

Date: 04/28/99





Bad die

Fair die

Good die

No info

Manually tagged